

SANYO Semiconductors DATA SHEET

LA6537—

For CD and CD-ROMs 4-Channel Bridge Driver

Overview

The LA6537 is a 4-channel bridge (BTL) driver which was developed for compact discs and CD-ROMs.

Features

- 4-channel bridge (BTL) power amplifier.
- IO max 700mA.
- With mute circuit (Amp 3, Amp 4).

Specifications

Absolute Maximum Ratings at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Maximum supply voltage	V _{CC} max		14	V
Maximum input voltage	V _{INB}		13	V
Mute pin voltage	VMUTE		13	V
Allowable power dissipation	Pd max	Mounted on the specified board *	2.5	W
Operating temperature	Topr		-20 to +75	°C
Storage temperature	Tstg		-55 to +150	°C

^{*} Specified board : 114.3mm \times 76.1mm \times 1.6mm, glass epoxy board

Recommended Operating Conditions at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Supply voltage	V _{CC}		4 to 13	V

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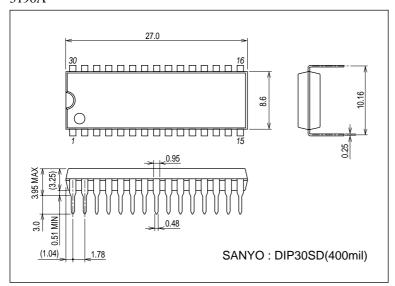
Electrical Characteristics at Ta = 25°C, $V_{CC} = 7.5V$

Parameter	Cumbal	Conditions		Unit		
Farameter	Symbol	Conditions	min	typ	max	Offic
No-load current drain	I _{CC} 1	Note 1	20	40	60	mA
	I _{CC} 2	Note 2		26	60	mA
Output offset voltage	V _{OF} 1	Note 3 : amplifiers 1 to 2, 7 to 8	-50		+50	mV
	V _{OF} 2	Note 3 : amplifiers 3 to 4, 5 to 6	-50		+50	mV
Input bias current	I _B			100	500	nA
Buffer input voltage range	V _{BIN}		1.5		V _{CC} -1.5	V
Input voltage range	V _{IN}		1.0		V _{CC} -1.5	V
Output source voltage	V _O 1	Note 4 : $R_L = 8.0\Omega$	5.0	5.6		V
Output sink voltage	V _O 2	Note 5 : R _L = 8.0Ω		1.8	2.4	V
Closed-circuit voltage gain	VG	Bridge amplifier		12		dB
Slew rate	SR			0.15		V/μs
Mute on voltage	VMUTE			2		V
Mute pin inflow current	IMUTE			60		μА

- Note: 1. Mute off and buffer in assume 0.5V.
 - 2. Mute off and buffer in assume 1/2 $V_{\mbox{CC}}$ V.
 - 3. Represents the interoutput difference.
 - 4. Voltage relative to ground (source) when an 8Ω load is connected between bridge amplifier outputs.
 - 5. Voltage relative to ground (sink) when an 8Ω load is connected between bridge amplifier outputs. Thus, muting is activated when high, and the amplifier outputs 5 and 6 are off.

Package Dimensions

unit : mm (typ) 3196A

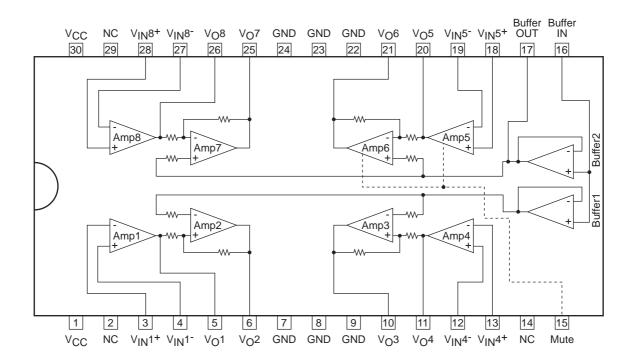


Test Method

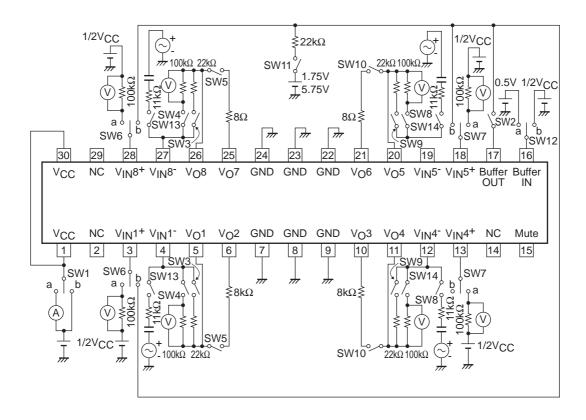
SW No.	1	2	3	4	5	6	7	8	9	10	11	12	13	14
I _{CC} 1	а	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	b	OFF	OFF
I _{CC} 2	а	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	а	OFF	OFF
V _{OF} 1, 2	b	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	b	OFF	OFF
IB	b	OFF	OFF	ON	OFF	а	а	ON	OFF	OFF	OFF	b	OFF	OFF
V _O 1	b	OFF	ON	OFF	ON	b	а	OFF	OFF	OFF	ON	b	OFF	OFF
V _O 2	b	OFF	OFF	OFF	OFF	а	b	OFF	ON	ON	ON	b	OFF	OFF
V _{MUTE}	b	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	b	OFF	OFF
IMUTE	b	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	b	OFF	OFF
VG	b	ON	ON	OFF	OFF	b	b	OFF	ON	OFF	OFF	b	ON	ON

- 1. For ICC1 and 2, measure the inflow current on the VCC pin.
- 2. For V_{OF}1 and 2, measure the voltage between pins 5 and 6 (amplifiers 1 and 2), pins 25 and 26 (amplifiers 7 and 8), pins 10 and 11 (amplifiers 3 and 4), and pins 20 and 21 (amplifiers 5 and 6).
- 3. For IB, measure the voltage across the $100k\Omega$ resistor (IB = V/100k Ω).
- 4. For VO1 and 2, measure each output voltage at input voltages 1.75V and 5.75V, respectively.
- 5. V_{MUTE} is the mute pin (pin 15) voltage when the output goes off.
- 6. IMUTE is the mute pin (pin 15) inflow current when the output goes off.
- 7. For VG, measure the voltage between pins 5 and 6 (amplifiers 1 and 2), pins 25 and 26 (amplifiers 7 and 8), pins 10 and 11 (amplifiers 3 and 4), and pins 20 and 21 (amplifiers 5 and 6) at f = 1 kHz, and use the following formula : $VG = 20 \log V_O/V_{IN} \, dB$.

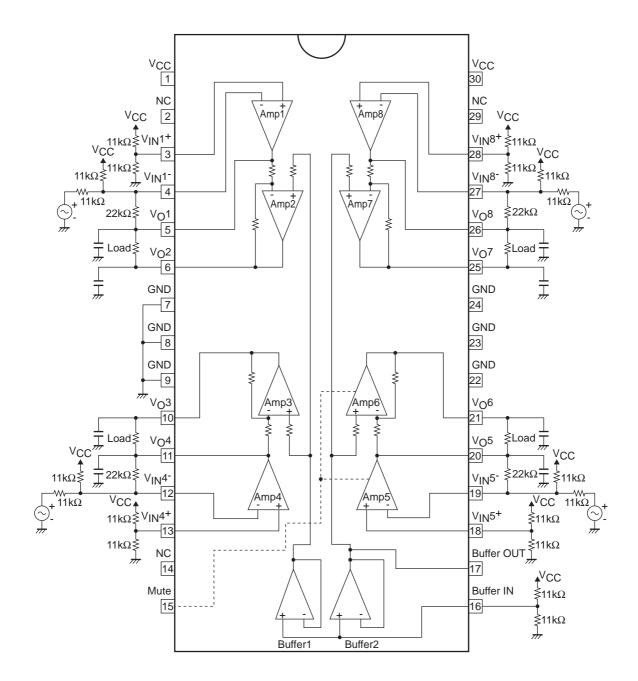
Pin Assignment and Block Diagram



Test Circuit



Sample Application Circuit



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